

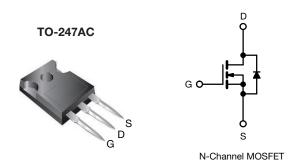
www.vishay.com

Vishay Siliconix

HALOGEN

FREE

EF Series Power MOSFET With Fast Body Diode



PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	650			
R _{DS(on)} typ. (Ω) at 25 °C	V _{GS} = 10 V	0.023		
Q _g max. (nC)	227			
Q _{gs} (nC)	63			
Q _{gd} (nC)	36			
Configuration	Single			

FEATURES

- 4th generation E series technology
- Low figure-of-merit (FOM) Ron x Qa
- Low effective capacitance (Co(er))
- · Reduced switching and conduction losses
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Solar (PV inverters)

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free and halogen-free	SiHG026N60EF-GE3

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-source voltage			V_{DS}	600	V		
Gate-source voltage			V_{GS}	± 30			
Continuous drain current (T _J = 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I _D	95	Α		
		T _C = 100 °C		60			
Pulsed drain current ^a			I _{DM}	286	i		
Linear derating factor				4.2	W/°C		
Single pulse avalanche energy b			E _{AS}	596	mJ		
Maximum power dissipation			P _D	521	W		
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C		
Drain-source voltage slope $T_J = 125 ^{\circ}\text{C}$		dv/dt	100	V/ns			
Reverse diode dv/dt ^d			50				
Soldering recommendations (peak temperature) ^c	For 10 s			260	°C		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature
- b. V_{DD} = 120 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 6.5 A
- c. 1.6 mm from case
- d. $I_{SD} \le I_D$, di/dt = 140 A/ μ s, starting $T_J = 25$ °C



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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum junction-to-ambient	R _{thJA}	-	40	°C/W		
Maximum junction-to-case (drain)	R _{thJC}	-	0.24	G/VV		

PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT
Static		•			•	•	
Drain-source breakdown voltage	V _{DS}	V _{GS} =	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.58	-	V/°C
Gate-source threshold voltage (N)	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		-	5.0	V
Cata acuraa laakaga	1	,	$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
Gate-source leakage	I_{GSS}	,	V _{GS} = ± 30 V	-	-	± 1	μΑ
Zava gota valtaga drain august		V _{DS} =	: 480 V, V _{GS} = 0 V	-	-	1	μΑ
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 480 \text{ V}$	', V _{GS} = 0 V, T _J = 125 °C	-	-	2	mA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 38 A	-	0.023	0.026	Ω
Forward transconductance a	9 _{fs}	V_{DS}	= 40 V, I _D = 38 A	-	9	-	S
Dynamic							
Input capacitance	C _{iss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$ $f = 1 \text{ MHz}$		7926	-	-
Output capacitance	C _{oss}	Ţ			301	-	
Reverse transfer capacitance	C _{rss}	1			6	-	_
Effective output capacitance, energy related ^a	C _{o(er)}	V 0Vto 490 V V 0 V		-	219	-	pF
Effective output capacitance, time related ^b	C _{o(tr)}	V _{DS} = 0	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$		1212	-	
Total gate charge	Qg			-	151	227	
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 38 \text{ A}, V_{DS} = 480 \text{ V}$		63	-	nC
Gate-drain charge	Q _{gd}	1			36	-	
Turn-on delay time	t _{d(on)}			-	78	117	
Rise time	t _r		$V_{DD} = 480 \text{ V}, I_{D} = 38 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{g} = 9.1 \Omega$		132	198	- ns
Turn-off delay time	t _{d(off)}	V _{GS} =			133	200	
Fall time	t _f				65	98	
Gate input resistance	R_g	f = 1 MHz, open drain		0.4	0.9	1.8	Ω
Drain-Source Body Diode Characteristic	cs						
Continuous source-drain diode current	I _S	showing the	MOSFET symbol showing the		-	95	
Pulsed diode forward current	I _{SM}	integral reverse p - n junction diode		-	-	286	A
Diode forward voltage	V _{SD}	T _J = 25 °C, I _S = 38 A, V _{GS} = 0 V		-	-	1.2	V
Reverse recovery time	t _{rr}		1,0 20 0,13 007,143 00		190	380	ns
Reverse recovery charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = I_S = 38 \text{A},$ $di/dt = 100 \text{A/}\mu\text{s}, V_R = 400 \text{V}$		-	1.7	3.4	μC
Reverse recovery current	I _{RRM}			-	16	-	A

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}

b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

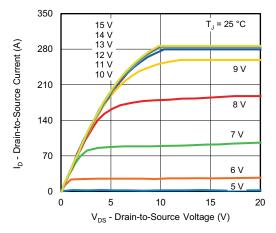


Fig. 1 - Typical Output Characteristics

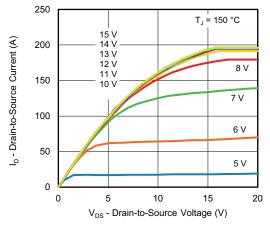


Fig. 2 - Typical Output Characteristics

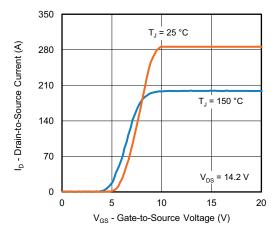


Fig. 3 - Typical Transfer Characteristics

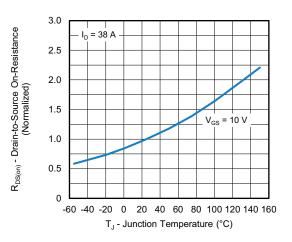


Fig. 4 - Normalized On-Resistance vs. Temperature

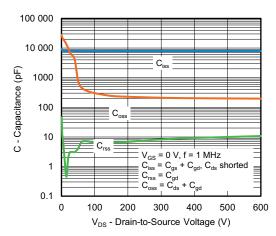


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

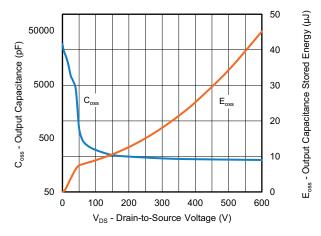


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



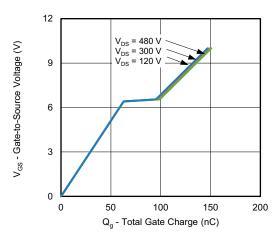


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

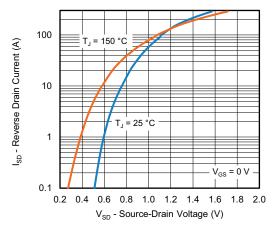


Fig. 8 - Typical Source-Drain Diode Forward Voltage

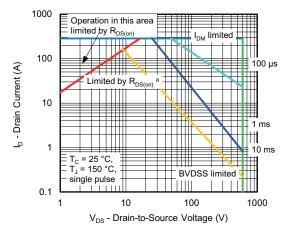


Fig. 9 - Maximum Safe Operating Area



a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

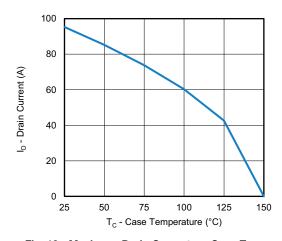


Fig. 10 - Maximum Drain Current vs. Case Temperature

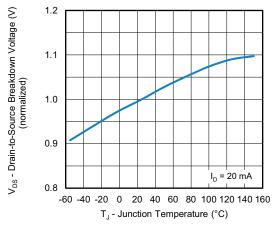


Fig. 11 - Temperature vs. Drain-to-Source Voltage



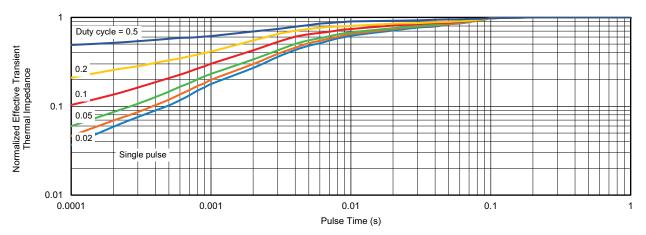


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case

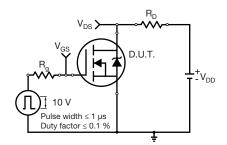


Fig. 13 - Switching Time Test Circuit

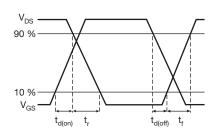


Fig. 14 - Switching Time Waveforms

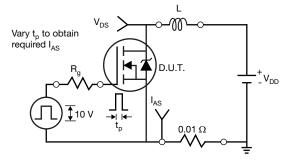


Fig. 15 - Unclamped Inductive Test Circuit

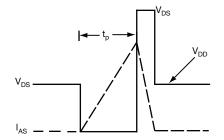


Fig. 16 - Unclamped Inductive Waveforms

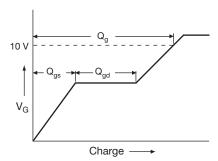


Fig. 17 - Basic Gate Charge Waveform

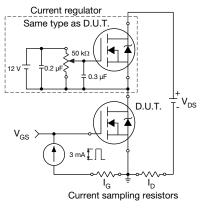
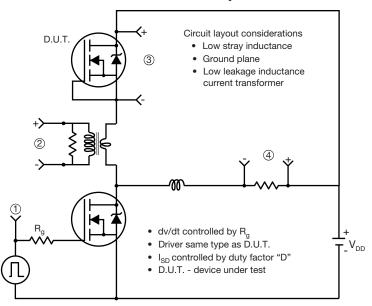


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dv/dt Test Circuit



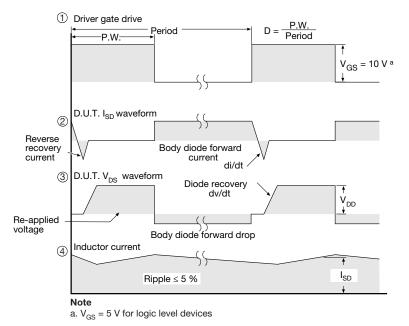


Fig. 19 - For N-Channel

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